

Search Notes

Application/Control No.

10/552,487

Examiner

Patricia T. Nguyen

Applicant(s)/Patent under
Reexamination

YAMAKAWA ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	289	8/27/2007	PN
	295		
	296		
455	127.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		